Application No.: 10/821,872

AMENDMENTS TO THE CLAIMS

1. (Currently Amended) A semiconductor device comprising:

a semiconductor substrate having a main surface;

a semiconductor element, having side surfaces, formed on said main surface;

an interlayer insulating film having a top surface and a peripheral edge extending from said top surface to said main surface, and formed on said main surface to cover said semiconductor element, wherein in said interlayer insulating film, separate spaced apart strip-like first and second groove portions are formed to be placed between a first side surface of said semiconductor element and said peripheral edge, to extend in parallel with said main surface and to extend in a predetermined direction at a spacing with each other, and a plurality of third groove portions are formed, between the first side surfaces of said semiconductor element and said peripheral edge, to diverge from said first and second groove portions and to extend in a direction different from an extending direction of said first and second groove portions; and

- a metal filling said first, second and, third groove portions.
- 2. (Original) The semiconductor device according to claim 1, wherein said third groove portion is formed between said first groove portion and said second groove portion.
- 3. (Original) The semiconductor device according to claim 1, wherein said third groove portion links said first groove portion and said second groove portion.
- 4. (Original) The semiconductor device according to claim 1, wherein said first, second and third groove portions reach said main surface from said top surface.

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5. (Original) The semiconductor device according to claim 1, wherein said first and

second groove portions are formed along said peripheral edge to surround a region where said

semiconductor element is formed.

6. (Original) The semiconductor device according to claim 1, wherein said

interlayer insulating film includes first and second portions of different types from each other

and successively formed on said main surface.

7. (Currently Amended) A semiconductor device comprising:

a semiconductor substrate having a main surface;

a semiconductor element formed on said main surface and having sid surfaces;

an interlayer insulating film having a top surface and a peripheral edge extending from

said top surface to said main surface, and formed on said main surface to cover said

semiconductor element, wherein in said interlayer insulating film, strip-like first and second

groove portions are formed to be placed between a first side surface of said semiconductor

element and said peripheral edge, to extend in parallel with said main surface and to extend to

cross each other at predetermined spacing; and

a metal filling said first and second groove portions, wherein said first and second groove

portions contiguously extend along the first side surface of said semiconductor element.

8. (Original) The semiconductor device according to claim 7, wherein said first and

second groove portions reach said main surface from said top surface.

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9. (Original) The semiconductor device according to claim 7, wherein said first and second groove portions are formed along said peripheral edge to surround a region where said semiconductor element is formed.

10. (Original) The semiconductor device according to claim 7, wherein said interlayer insulating film includes first and second portions of different types from each other and successively formed on said main surface.